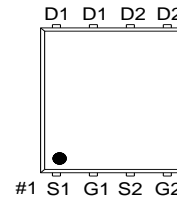
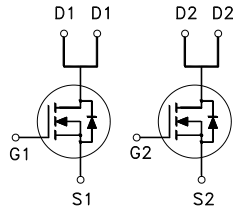




PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
100V	110mΩ	8.4A



ABSOLUTE MAXIMUM RATINGS ($T_A = 25\text{ °C}$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	100	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain Current	$T_C = 25\text{ °C}$	I_D	8.4	A
	$T_C = 100\text{ °C}$		5.3	
	$T_A = 25\text{ °C}$		2.4	
	$T_A = 70\text{ °C}$		1.9	
Pulsed Drain Current ¹		I_{DM}	15	
Avalanche Current		I_{AS}	6.1	
Avalanche Energy	$L = 1\text{mH}$	E_{AS}	19	mJ
Power Dissipation	$T_C = 25\text{ °C}$	P_D	18	W
	$T_C = 100\text{ °C}$		7.3	
	$T_A = 25\text{ °C}$		1.5	
	$T_A = 70\text{ °C}$		0.9	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ²	$R_{\theta JA}$		85	°C / W
Junction-to-Case	$R_{\theta JC}$		6.8	

¹Pulse width limited by maximum junction temperature.

²The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25\text{ °C}$

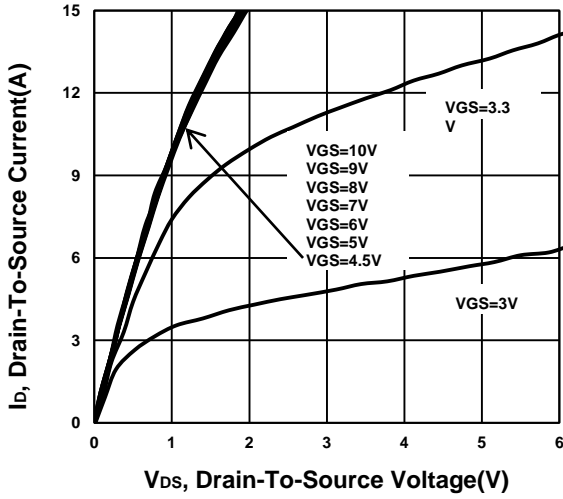
ELECTRICAL CHARACTERISTICS (T_J = 25 °C, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0V, I _D = 250μA	100			V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} = V _{GS} , I _D = 250μA	1	1.8	3	
Gate-Body Leakage	I _{GSS}	V _{DS} = 0V, V _{GS} = ±20V			±100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 100V, V _{GS} = 0V			1	μA
		V _{DS} = 100V, V _{GS} = 0V, T _J = 55 °C			10	
Drain-Source On-State Resistance ¹	R _{DS(ON)}	V _{GS} = 4.5V, I _D = 6A		89	120	mΩ
		V _{GS} = 10V, I _D = 6A		83	110	
Forward Transconductance ¹	g _{fs}	V _{DS} = 10V, I _D = 6A		25		S
DYNAMIC						
Input Capacitance	C _{iss}	V _{GS} = 0V, V _{DS} = 25V, f = 1MHz	493	617	740	pF
Output Capacitance	C _{oss}		43	54	65	
Reverse Transfer Capacitance	C _{rss}		18	31	43	
Gate Resistance	R _g	V _{GS} = 0V, V _{DS} = 0V, f = 1MHz	0.8	1.6	2.4	Ω
Total Gate Charge ²	Q _{g(VGS=10V)}	V _{DS} = 50V, I _D = 6A	10	13	15.6	nC
	Q _{g(VGS=4.5V)}		6	7.7	9.2	
Gate-Source Charge ²	Q _{gs}		1.5	1.9	2.3	
Gate-Drain Charge ²	Q _{gd}		2.5	4.2	6	
Turn-On Delay Time ²	t _{d(on)}		V _{DD} = 50V I _D ≅ 6A, V _{GEN} = 10V, R _G = 6Ω		9.5	
Rise Time ²	t _r			15		
Turn-Off Delay Time ²	t _{d(off)}			22		
Fall Time ²	t _f			30		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (T_J = 25 °C)						
Continuous Current ³	I _S				8.4	A
Forward Voltage ¹	V _{SD}	I _F = 6A, V _{GS} = 0V			1.4	V
Reverse Recovery Time	t _{rr}	I _F = 6A, di _F /dt = 100A / μS	11	23	35	nS
Reverse Recovery Charge	Q _{rr}		11	23	35	nC

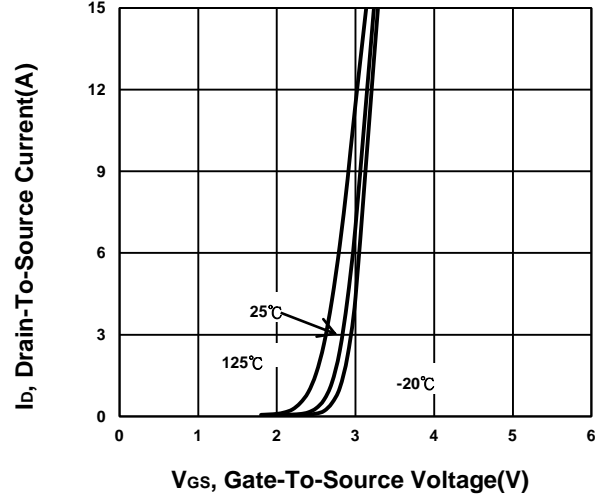
¹Pulse test : Pulse Width ≤ 300 μsec, Duty Cycle ≤ 2%.

²Independent of operating temperature.

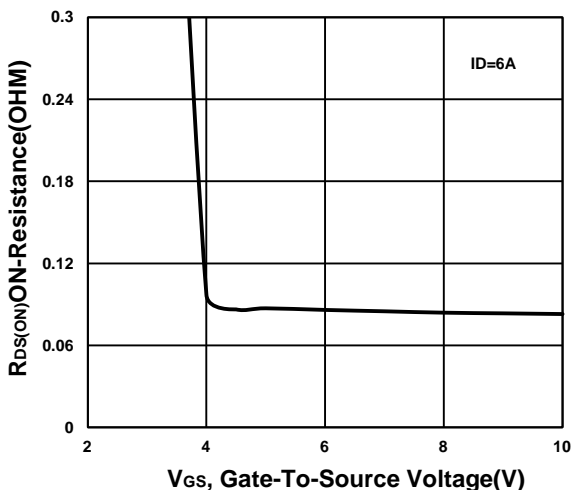
Output Characteristics



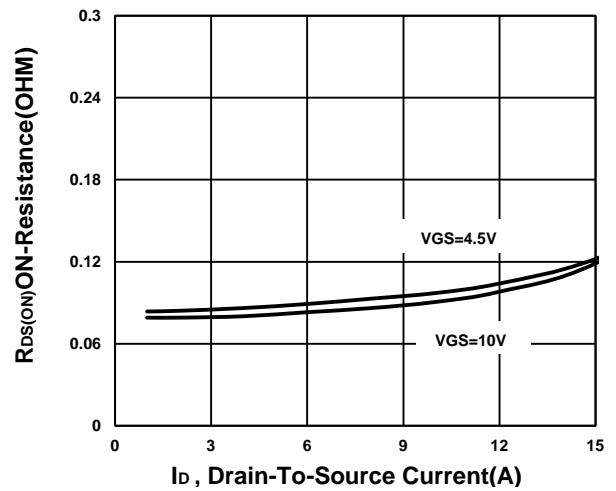
Transfer Characteristics



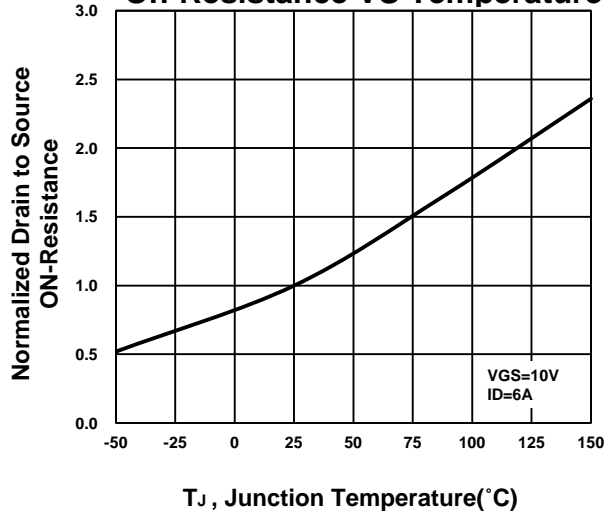
On-Resistance VS Gate-To-Source Voltage



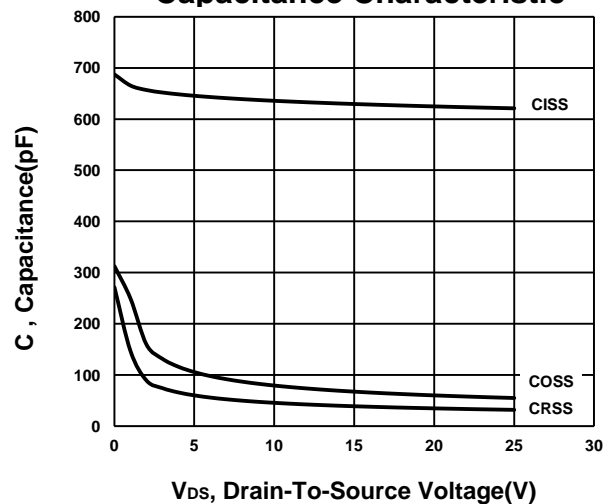
On-Resistance VS Drain Current

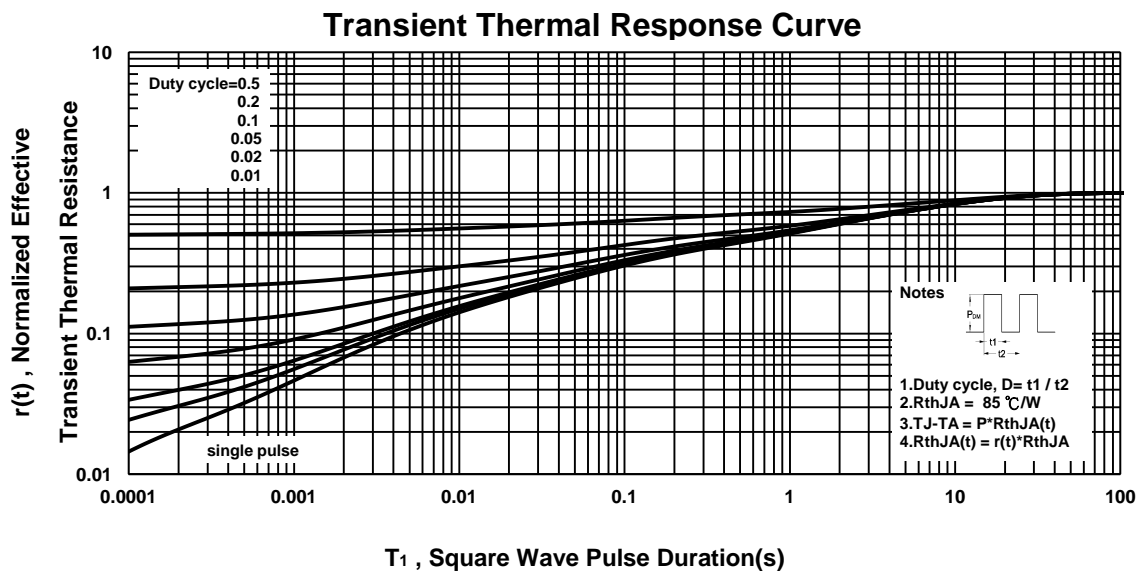
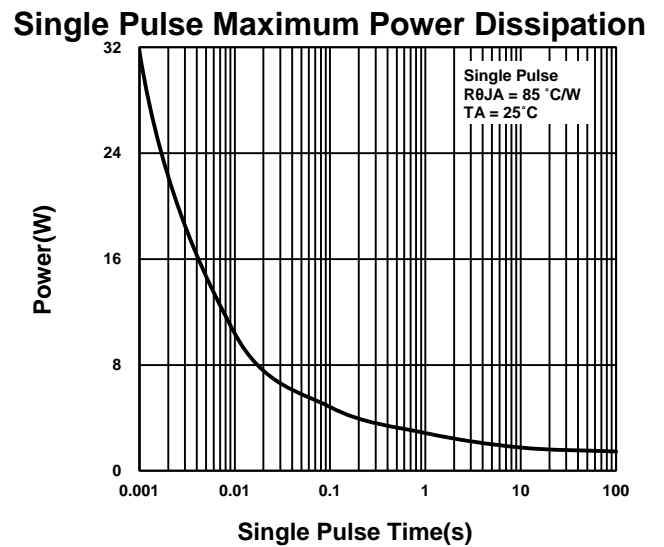
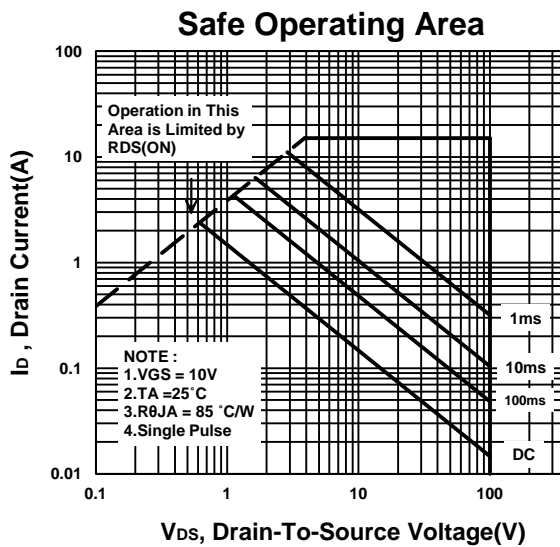
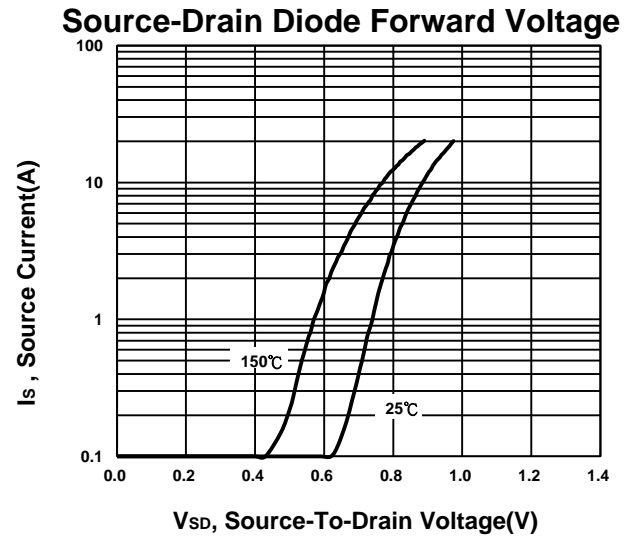
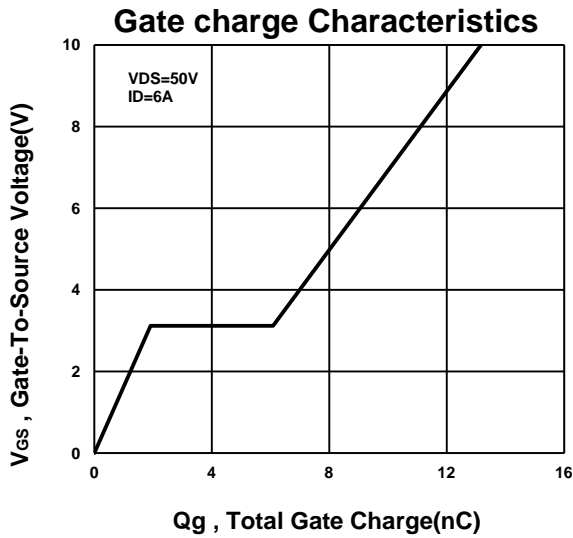


On-Resistance VS Temperature

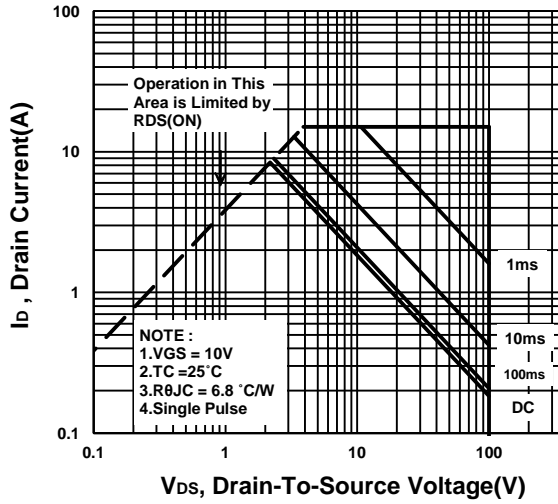


Capacitance Characteristic

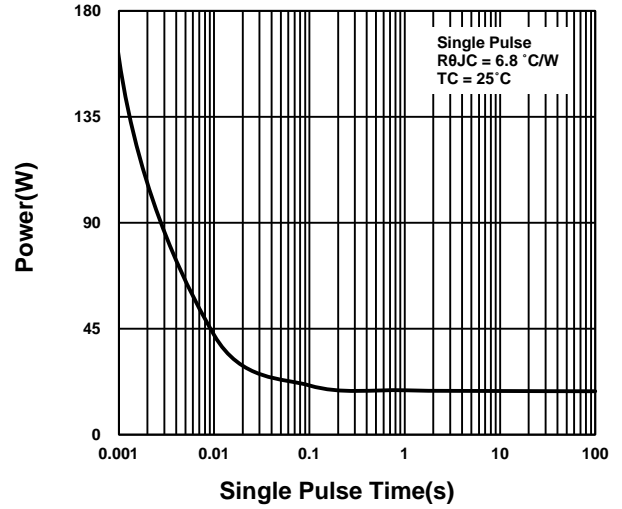




Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

